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# Microwave Wideband Synthesizer with Integrated VCO

Data Sheet ADF4355-2

#### **FEATURES**

RF output frequency range: 54 MHz to 4400 MHz
Fractional-N synthesizer and integer-N synthesizer
High resolution 38-bit modulus
Low phase noise, VCO
Programmable divide by 1, 2, 4, 8, 16, 32, or 64 output
Analog and digital power supplies: 3.3 V
Charge pump and VCO power supplies: 5 V typical
Logic compatibility: 1.8 V
Programmable dual modulus prescaler of 4/5 or 8/9
Programmable output power level
RF output mute function

#### **APPLICATIONS**

3-wire serial interface

Analog and digital lock detect

Wireless infrastructure (W-CDMA, TD-SCDMA, WiMAX, GSM, PCS, DCS, DECT)
Point to point/point to multipoint microwave links Satellites/VSATs
Test equipment/instrumentation
Clock generation

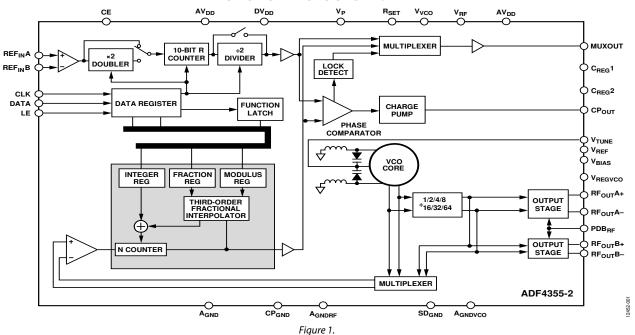
#### **GENERAL DESCRIPTION**

The ADF4355-2 allows implementation of fractional-N or integer-N phase-locked loop (PLL) frequency synthesizers when used with an external loop filter and an external reference frequency. A series of frequency dividers permits operation from 54 MHz to 4400 MHz.

The ADF4355-2 has an integrated voltage controlled oscillator (VCO) with a fundamental output frequency ranging from 3400 MHz to 6800 MHz. In addition, the VCO frequency is connected to divide by 1, 2, 4, 8, 16, 32, or 64 circuits that allow the user to generate radio frequency (RF) output frequencies as low as 54 MHz. For applications that require isolation, the RF output stage can be muted. The mute function is both pin and software controllable.

Control of all on-chip registers is through a simple 3-wire interface. The ADF4355-2 operates with analog and digital power supplies, ranging from 3.15 V to 3.45 V, with charge pump and VCO supplies from 4.75 V to 5.25 V. The ADF4355-2 also contains hardware and software power-down modes.

#### **FUNCTIONAL BLOCK DIAGRAM**



### ADF4355-2\* PRODUCT PAGE QUICK LINKS

Last Content Update: 02/23/2017

### COMPARABLE PARTS 🖵

View a parametric search of comparable parts.

#### **EVALUATION KITS**

- ADF4355-2 Evaluation Board
- ADL5567 & AD9625 Analog Signal Chain Evaluation and ADF4355-2 Wideband Synthesizer with VCO

#### **DOCUMENTATION**

#### **Application Notes**

 AN-1381: How to Bypass VCO Calibration for the ADF4355-2

#### **Data Sheet**

 ADF4355-2: Wideband Synthesizer with Integrated VCO Data Sheet

#### **User Guides**

 UG-804: Evaluating the ADF4355-2 Fractional-N/Integer-N PLL Frequency Synthesizer

### **TOOLS AND SIMULATIONS**

ADIsimPLL™

#### REFERENCE DESIGNS 🖵

• CN0369

### REFERENCE MATERIALS 🖵

#### **Technical Articles**

 Low Cost PLL with Integrated VCO Enables Compact LO Solutions

#### DESIGN RESOURCES $\Box$

- · ADF4355-2 Material Declaration
- PCN-PDN Information
- · Quality And Reliability
- Symbols and Footprints

### DISCUSSIONS 🖳

View all ADF4355-2 EngineerZone Discussions.

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Visit the product page to see pricing options.

### TECHNICAL SUPPORT

Submit a technical question or find your regional support number.

### DOCUMENT FEEDBACK 🖳

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#### **REVISION HISTORY**

1/16—Rev. A to Rev. B	
Added Doubler Enabled Parameter to Table 1	4
Changes to Table 2	6
Changes to Table 3	7
Changes to Reference Input Section and INT, FRAC, MO	D, and
R Counter Relationship Section	
Changes to Figure 25	14
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Changes to Power Supplies Section and Figure 45	35
2/15—Rev. 0 to Rev. A	
Changes to General Description Section	1
Changes to Table 1	3
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Changes to Figure 21 Caption	11
Changes to Reference Input Section and INT, FRAC, MC	D, and
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Changes to Figure 25 and Input Shift Registers Section	3
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Changes to Figure 281	6
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Changes to Figure 322	0
Changes to Phase Resync Section2	1
Changes to Figure 342	2
Changes to Reference Mode Section, Counter Reset Section,	
Register 5 Section, and Figure 352	3
Changes to Negative Bleed Section and Feedback Select Section 2	4
Changes to Figure 38 Caption and Register 8 Section2	7
Changed ADC Conversion Clock (ADC_CLK) Section to ADC	$\mathbb{C}$
Clock Divider (ADC_CLK_DIV) Section2	8
Changes to ADC Clock Divider (ADC_CLK_DIV) Section2	8
Changes to Register Initialization Sequence Section and	
Frequency Update Sequence Section2	9
Changes to RF Synthesizer—A Worked Example Section3	0
Changes to Lock Time Section3	1
Added Lock Time—A Worked Example Section3	
Changes to Figure 453	

10/14—Revision 0: Initial Version

### **SPECIFICATIONS**

 $AV_{\rm DD} = DV_{\rm DD} = V_{\rm RF} = 3.3~V~\pm~5\%,~4.75~V \leq V_{\rm P} = V_{\rm VCO} \leq 5.25~V,~A_{\rm GND} = CP_{\rm GND} = A_{\rm GNDVCO} = SD_{\rm GND} = A_{\rm GNDRF} = 0~V,~R_{\rm SET} = 5.1~k\Omega,~dBm~referred~to~50~\Omega,~T_{\rm A} = T_{\rm MIN}~to~T_{\rm MAX},~unless~otherwise~noted.$ 

Table 1.

Parameter	Symbol	Min	Тур	Max	Unit	Test Conditions/Comments
REF <sub>IN</sub> A/REF <sub>IN</sub> B CHARACTERISTICS						
Input Frequency						For f < 10 MHz, ensure slew rate > 21 V/ $\mu$ s
Single-Ended Mode		10		250	MHz	
Differential Mode		10		600	MHz	
Doubler Enabled				100	MHz	Doubler is set in Register 4, Bit DB26
Input Sensitivity						
Single-Ended Mode		0.4		$AV_DD$	V p-p	REF <sub>IN</sub> A biased at AV <sub>DD</sub> /2; ac coupling ensures AV <sub>DD</sub> /2 bias
Differential Mode		0.4		1.8	V p-p	LVDS and LVPECL compatible, REF <sub>IN</sub> A/REF <sub>IN</sub> B biased at 2.1 V; ac coupling ensures 2.1 V bias
Input Capacitance						
Single-Ended Mode			6.9		pF	
Differential Mode			1.4		рF	
Input Current				±60	μA	Single-ended reference programmed
·				±250	μA	Differential reference programmed
Phase Detector Frequency				125	MHz	
CHARGE PUMP (CP)						
Charge Pump Current, Sink/Source	I <sub>CP</sub>					$R_{SET} = 5.1 \text{ k}\Omega$
High Value	16.		4.8		mA	132. 511.125
Low Value			0.3		mA	
R <sub>SET</sub> Range			5.1		kΩ	Fixed
Current Matching			3		%	$0.5 \text{ V} \le \text{V}_{CP}^{1} \le \text{V}_{P} - 0.5 \text{ V}$
ICP VS. VCP			3		%	$0.5 \text{ V} \le \text{V}_{CP}^{1} \le \text{V}_{P} - 0.5 \text{ V}$
I <sub>CP</sub> vs. Temperature			1.5		%	$V_{CP}^1 = 2.5 \text{ V}$
LOGIC INPUTS			1.5		70	VCF - 2.5 V
Input High Voltage	V <sub>INH</sub>	1.5			V	
Input Low Voltage	VINH	1.5		0.6	V	
Input Low Voltage Input Current						
•	I <sub>INH</sub> /I <sub>INL</sub>		2.0	±1	μA	
Input Capacitance	C <sub>IN</sub>		3.0		pF	
LOGIC OUTPUTS		51.			l	
Output High Voltage	V <sub>OH</sub>	DV <sub>DD</sub> – 0.4			V	
		1.5	1.8		V	1.8 V output selected
Output High Current	Іон			500	μΑ	
Output Low Voltage	V <sub>OL</sub>			0.4	V	$I_{OL}^2 = 500 \mu\text{A}$
POWER SUPPLIES						
Analog Power	$AV_DD$	3.15		3.45	V	
Digital Power and RF Supply Voltage	DV <sub>DD</sub> , V <sub>RF</sub>		$AV_DD$			Voltages must equal AVDD
Charge Pump and VCO Voltage	$V_P$ , $V_{VCO}$	4.75	5.0	5.25	V	V <sub>P</sub> must equal V <sub>VCO</sub>
Charge Pump Supply Power Current	I <sub>P</sub>		8	9		
Digital Power Supply Current + Analog Power Supply Current <sup>3</sup>	DI <sub>DD</sub> , AI <sub>DD</sub>		62	69	mA	
Output Dividers			6 to 36		mA	Each output divide by 2 consumes 6 mA
Supply Current	l <sub>vco</sub>		70	85	mA	
RF <sub>OUT</sub> A±/RF <sub>OUT</sub> B± Supply Current	I <sub>RF<sub>OUT</sub>x±</sub>		16/20/ 42/55 <sup>4</sup>	20/35/ 50/70 <sup>4</sup>	mA	RF output stage is programmable; RF <sub>OUT</sub> B+/RF <sub>OUT</sub> B– powered off
Low Power Sleep Mode			500		μΑ	Hardware power-down
•			1000		μΑ	Software power-down

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Parameter	Symbol	Min	Тур	Max	Unit	Test Conditions/Comments
RF OUTPUT CHARACTERISTICS			*			
VCO Frequency Range		3400		6800	MHz	Fundamental VCO range
RF Output Frequency		53.125		4400	MHz	
VCO Sensitivity	K <sub>V</sub>		15		MHz/V	
Frequency Pushing (Open-Loop)			15		MHz/V	
Frequency Pulling (Open-Loop)			0.5		MHz	Voltage standing wave ratio (VSWR) = 2:1
Harmonic Content						
Second			-27		dBc	Fundamental VCO output (RFoutA+)
			-22		dBc	Divided VCO output (RFou⊤A+)
Third			-20		dBc	Fundamental VCO output (RFoutA+)
			-12		dBc	Divided VCO output (RFoutA+)
RF Output Power⁵			8		dBm	RF <sub>OUT</sub> A+ = 1 GHz
·			3		dBm	RFoutA+/RFoutA- = 4.4 GHz
RF Output Power Variation			±1		dB	RFoutA+/RFoutA- = 4.4 GHz
RF Output Power Variation (over Frequency)			±3		dB	$RF_{OUT}A+/RF_{OUT}A-=1$ GHz to 4.4 GHz
Level of Signal with RF Output Disabled			-60		dBm	RFoutA+/RFoutA- = 1 GHz, VCO = 4 GHz
			-30		dBm	RFOUTA+/RFOUTA- = 4.4 GHz, VCO = 4.4 GHz
NOISE CHARACTERISTICS						
Fundamental VCO Phase Noise Performance						VCO noise in open-loop conditions
			-116		dBc/Hz	100 kHz offset from 3.4 GHz carrier
			-136		dBc/Hz	800 kHz offset from 3.4 GHz carrier
			-138		dBc/Hz	1 MHz offset from 3.4 GHz carrier
			-155		dBc/Hz	10 MHz offset from 3.4 GHz carrier
			-113		dBc/Hz	100 kHz offset from 5.0 GHz carrier
			-133		dBc/Hz	800 kHz offset from 5.0 GHz carrier
			-135		dBc/Hz	1 MHz offset from 5.0 GHz carrier
			-153		dBc/Hz	10 MHz offset from 5.0 GHz carrier
			-110		dBc/Hz	100 kHz offset from 6.8 GHz carrier
			-130		dBc/Hz	800 kHz offset from 6.8 GHz carrier
			-132		dBc/Hz	1 MHz offset from 6.8 GHz carrier
			-150		dBc/Hz	10 MHz offset from 6.8 GHz carrier
Normalized In-Band Phase Noise Floor						
Fractional Channel <sup>6</sup>			-221		dBc/Hz	
Integer Channel <sup>7</sup>			-223		dBc/Hz	
Normalized 1/f Noise, PN <sub>1_f</sub> 8			-116		dBc/Hz	10 kHz offset; normalized to 1 GHz
Integrated RMS Jitter			150		fs	
Spurious Signals due to Phase Frequency Detector (PFD) Frequency			-80		dBc	

 $<sup>^{1}</sup>$  V<sub>CP</sub> is the voltage at the CP<sub>OUT</sub> pin.

<sup>&</sup>lt;sup>2</sup> I<sub>OL</sub> is the output low current.

 $<sup>^{3}</sup>$  T<sub>A</sub> = 25°C; AV<sub>DD</sub> = DV<sub>DD</sub> = V<sub>RF</sub> = 3.3 V; V<sub>VCO</sub> = V<sub>P</sub> = 5.0 V; prescaler = 4/5; f<sub>REFIN</sub> = 122.88 MHz; f<sub>PFD</sub> = 61.44 MHz; and f<sub>RF</sub> = 1650 MHz.

<sup>&</sup>lt;sup>4</sup> The value measured varies between 16, 20, 42, and 55, depending on the RF output stage power programmable level per Bit DB4 and DB5 in Register 6.

<sup>&</sup>lt;sup>5</sup> RF output power using the EV-ADF4355-2SD1Z evaluation board measured into a spectrum analyzer, with board and cable losses de-embedded. The EV-ADF4355-2SD1Z RF outputs are pulled up externally using a 7.4 nH inductor. Unused RF output pins are terminated in 50 Ω.

<sup>&</sup>lt;sup>6</sup> Use this figure to calculate the phase noise for any application. To calculate in-band phase noise performance as seen at the VCO output, use the following formula: -221 + 10log(f<sub>PFD</sub>) + 20logN. The value given is the lowest noise mode for the fractional channel.

<sup>&</sup>lt;sup>7</sup> Use this figure to calculate the phase noise for any application. To calculate in-band phase noise performance as seen at the VCO output, use the following formula: –223 + 10log(f<sub>PFD</sub>) + 20logN. The value given is the lowest noise mode for the integer channel.

<sup>&</sup>lt;sup>8</sup> The PLL phase noise is composed of 1/f (flicker) noise plus the normalized PLL noise floor. The formula for calculating the 1/f noise contribution at an RF frequency ( $f_{RF}$ ) and at a frequency offset (f) is given by PN =  $P_{1\_f}$  + 10log(10 kHz/f) + 20log( $f_{RF}$ /1 GHz). Both the normalized phase noise floor and flicker noise are modeled in the ADIsimPLL design tool.

#### **TIMING CHARACTERISTICS**

 $AV_{DD} = DV_{DD} = V_{RF} = 3.3 \ V \pm 5\%, \ 4.75 \ V \leq V_P = V_{VCO} \leq 5.25 \ V, \ A_{GND} = CP_{GND} = A_{GNDVCO} = SD_{GND} = A_{GNDRF} = 0 \ V, \ R_{SET} = 5.1 \ k\Omega, \ dBm \ referred to 50 \ \Omega, \ T_A = T_{MIN} \ to \ T_{MAX}, \ unless \ otherwise \ noted.$ 

Table 2.

Parameter	Limit	Unit	Description
f <sub>CLK</sub>	50	MHz max	Serial peripheral interface CLK frequency
t <sub>1</sub>	10	ns min	LE setup time
$t_2$	5	ns min	DATA to CLK setup time
t <sub>3</sub>	5	ns min	DATA to CLK hold time
$t_4$	10	ns min	CLK high duration
<b>t</b> <sub>5</sub>	10	ns min	CLK low duration
t <sub>6</sub>	5	ns min	CLK to LE setup time
t <sub>7</sub>	20 or (2/f <sub>PFD</sub> ), whichever is longer	ns min	LE pulse width

#### **Timing Diagram**

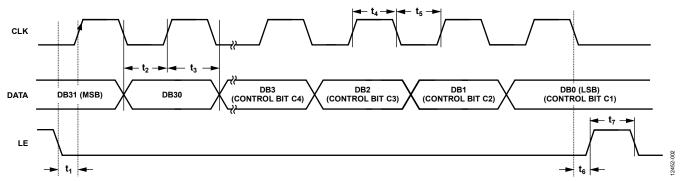


Figure 2. Timing Diagram

### **ABSOLUTE MAXIMUM RATINGS**

 $T_A = 25$ °C, unless otherwise noted.

Table 3.

Table 5.	
Parameter	Rating
V <sub>RF</sub> , DV <sub>DD</sub> , AV <sub>DD</sub> to GND <sup>1</sup>	-0.3 V to +3.6 V
$AV_{DD}$ to $DV_{DD}$	-0.3 V to +0.3 V
$V_P$ , $V_{VCO}$ to $GND^1$	-0.3 V to +5.8 V
CP <sub>OUT</sub> to GND <sup>1</sup>	$-0.3 \text{ V to V}_P + 0.3 \text{ V}$
Digital Input/Output Voltage to GND1	$-0.3 \text{ V to DV}_{DD} + 0.3 \text{ V}$
Analog Input/Output Voltage to GND <sup>1</sup>	$-0.3 \text{ V to AV}_{DD} + 0.3 \text{ V}$
REF <sub>IN</sub> A, REF <sub>IN</sub> B to GND <sup>1</sup>	$-0.3 \text{ V to AV}_{DD} + 0.3 \text{ V}$
REF <sub>IN</sub> A to REF <sub>IN</sub> B	±2.1 V
Operating Temperature Range	−40°C to +85°C
Storage Temperature Range	−65°C to +125°C
Maximum Junction Temperature	150°C
$\theta_{JA}$ , Thermal Impedance Paddle Soldered to GND <sup>1</sup>	27.3°C/W
Reflow Soldering	
Peak Temperature	260°C
Time at Peak Temperature	40 sec
Electrostatic Discharge (ESD)	
Charged Device Model	1000 V
Human Body Model	2500 V

 $<sup>^{1}</sup>$  GND =  $A_{GND}$  =  $SD_{GND}$  =  $A_{GNDRF}$  =  $A_{GNDVCO}$  =  $CP_{GND}$  = 0 V.

Stresses at or above those listed under Absolute Maximum Ratings may cause permanent damage to the product. This is a stress rating only; functional operation of the product at these or any other conditions above those indicated in the operational section of this specification is not implied. Operation beyond the maximum operating conditions for extended periods may affect product reliability.

The ADF4355-2 is a high performance RF integrated circuit with an ESD rating of 2500 V and is ESD sensitive. Take proper precautions for handling and assembly.

#### TRANSISTOR COUNT

The transistor count for the ADF4355-2 is 103,665 (CMOS) and 3214 (bipolar).

#### **ESD CAUTION**



**ESD** (electrostatic discharge) sensitive device. Charged devices and circuit boards can discharge without detection. Although this product features patented or proprietary protection circuitry, damage may occur on devices subjected to high energy ESD. Therefore, proper ESD precautions should be taken to avoid performance degradation or loss of functionality.

### PIN CONFIGURATION AND FUNCTION DESCRIPTIONS

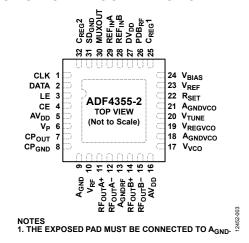


Figure 3. Pin Configuration

**Table 4. Pin Function Descriptions** 

Pin No.	Mnemonic	Description
1	CLK	Serial Clock Input. Data is clocked into the 32-bit shift register on the CLK rising edge. This input is a high impedance CMOS input.
2	DATA	Serial Data Input. The serial data is loaded most significant bit (MSB) first with the four least significant bits (LSBs) as the control bits. This input is a high impedance CMOS input.
3	LE	Load Enable, CMOS Input. When LE goes high, the data stored in the shift register is loaded into the register that is selected by the four LSBs.
4	CE	Chip Enable. A logic low on this pin powers down the device and puts the charge pump into three-state mode. A logic high on this pin powers up the device, depending on the status of the power-down bits.
5, 16	AV <sub>DD</sub>	Analog Power Supply. These pins range from 3.15 V to 3.45 V. Connect decoupling capacitors to the analog ground plane as close to these pins as possible. AV <sub>DD</sub> must have the same value as DV <sub>DD</sub> .
6	V <sub>P</sub>	Charge Pump Power Supply. $V_P$ must have the same value as $V_{VCO}$ . Connect decoupling capacitors to the ground plane as close to this pin as possible.
7	СРоит	Charge Pump Output. When enabled, this output provides $\pm I_{CP}$ to the external loop filter. The output of the loop filter is connected to $V_{TUNE}$ to drive the internal VCO.
8	CP <sub>GND</sub>	Charge Pump Ground. This output is the ground return pin for CP <sub>OUT</sub> .
9	$A_{GND}$	Analog Ground. Ground return pin for AV <sub>DD</sub> .
10	V <sub>RF</sub>	Power Supply for the RF Output. Connect decoupling capacitors to the analog ground plane as close to this pin as possible. V <sub>RF</sub> must have the same value as AV <sub>DD</sub> .
11	RF <sub>OUT</sub> A+	VCO Output. The output level is programmable. The VCO fundamental output or a divided down version is available.
12	RF <sub>OUT</sub> A-	Complementary VCO Output. The output level is programmable. The VCO fundamental output or a divided down version is available.
13	Agndre	RF Output Stage Ground. Ground return pins for the RF output stage.
14	RF <sub>OUT</sub> B+	Auxiliary VCO Output. The output level is programmable. The VCO fundamental output or a divided down version is available.
15	RF <sub>OUT</sub> B—	Complementary Auxiliary VCO Output. The output level is programmable. The VCO fundamental output or a divided down version is available.
17	V <sub>V</sub> CO	Power Supply for the VCO. The voltage on this pin ranges from 4.75 V to 5.25 V. Connect decoupling capacitors to the analog ground plane as close to this pin as possible.
18, 21	Agndvco	VCO Ground. Ground return path for the VCO.
19	V <sub>REGVCO</sub>	VCO Compensation Node. Connect decoupling capacitors to the ground plane as close to this pin as possible. Connect this pin directly to $V_{VCO}$ .
20	V <sub>TUNE</sub>	Control Input to the VCO. This voltage determines the output frequency and is derived from filtering the CP <sub>OUT</sub> output voltage. The capacitance at this pin (V <sub>TUNE</sub> input capacitance) is 9 pF.

Pin No.	Mnemonic	Description
22	R <sub>SET</sub>	Bias Current Resistor. Connecting a resistor between this pin and ground sets the charge pump output current.
23	V <sub>REF</sub>	Internal Compensation Node. DC biased at half the tuning range. Connect decoupling capacitors to the ground plane as close to this pin as possible.
24	V <sub>BIAS</sub>	Reference Voltage. Connect a 100 nF decoupling capacitor to the ground plane as close to this pin as possible.
25, 32	C <sub>REG</sub> 1, C <sub>REG</sub> 2	Outputs from the LDO Regulator. Pin 25 and Pin 32 are the supply voltages to the digital circuits. Nominal voltage of 1.8 V. Decoupling capacitors of 100 nF connected to A <sub>GND</sub> are required for these pins.
26	$PDB_{RF}$	RF Power-Down. A logic low on this pin mutes the RF outputs. This mute function is also software controllable.
27	$DV_{DD}$	Digital Power Supply. This pin must be at the same voltage as AV <sub>DD</sub> . Place decoupling capacitors to the ground plane as close to this pin as possible.
28	REF <sub>IN</sub> B	Complementary Reference Input. If unused, ac-couple this pin to A <sub>GND</sub> .
29	REFINA	Reference Input.
30	MUXOUT	Multiplexer Output. The multiplexer output allows the digital lock detect, the analog lock detect, scaled RF, or the scaled reference frequency to be externally accessible.
31	SD <sub>GND</sub>	Digital $\Sigma$ - $\Delta$ Modulator Ground. Pin 31 is the ground return path for the $\Sigma$ - $\Delta$ modulator.
	EP	Exposed Pad. The exposed pad must be connected to A <sub>GND</sub> .

### TYPICAL PERFORMANCE CHARACTERISTICS

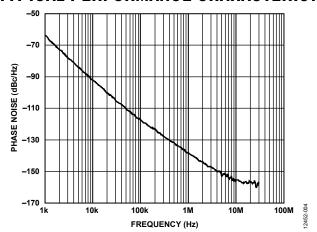


Figure 4. Open-Loop VCO Phase Noise, 3.4 GHz

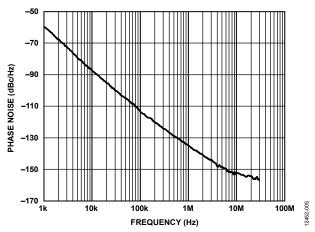


Figure 5. Open-Loop VCO Phase Noise, 5.0 GHz

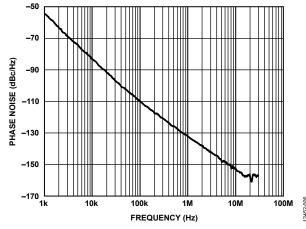


Figure 6. Open-Loop VCO Phase Noise, 6.8 GHz

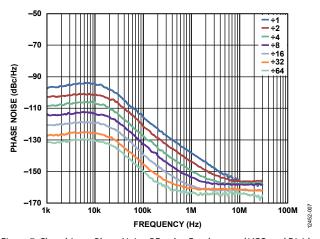


Figure 7. Closed-Loop Phase Noise, RF $_{OUT}A+$ , Fundamental VCO and Dividers, VCO = 3.4 GHz, PFD = 61.44 MHz, Loop Bandwidth = 20 kHz

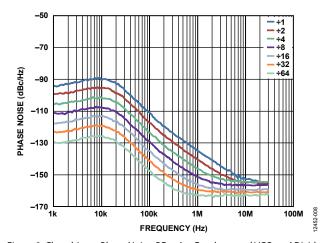


Figure 8. Closed-Loop Phase Noise, RF $_{
m OuT}$ A+, Fundamental VCO and Dividers, VCO = 5.0 GHz, PFD = 61.44 MHz, Loop Bandwidth = 20 kHz

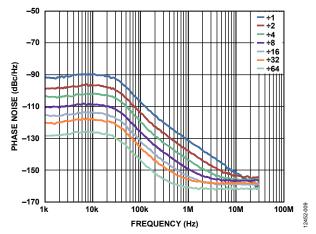


Figure 9. Closed-Loop Phase Noise, RF $_{OUT}A+$ , Fundamental VCO and Dividers, VCO = 6.8 GHz, PFD = 61.44 MHz, Loop Bandwidth = 20 kHz

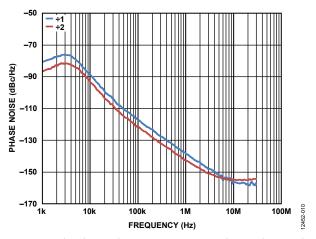


Figure 10. Closed-Loop Phase Noise,  $RF_{OUT}A+$ , Fundamental VCO and Divide by 2, VCO = 3.4 GHz, PFD = 61.44 MHz, Loop Bandwidth = 2 kHz

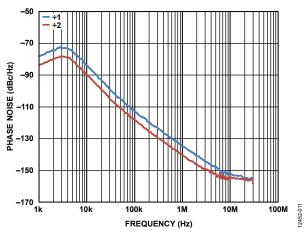


Figure 11. Closed-Loop Phase Noise, RF $_{OUT}A+$ , Fundamental VCO and Divide by 2, VCO = 5.0 GHz, PFD = 61.44 MHz, Loop Bandwidth = 2 kHz

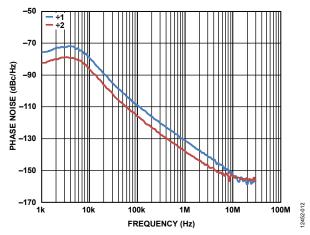


Figure 12. Closed-Loop Phase Noise, RF<sub>OUT</sub>A+, Fundamental VCO and Divide by 2, VCO = 6.8 GHz, PFD = 61.44 MHz, Loop Bandwidth = 2 kHz

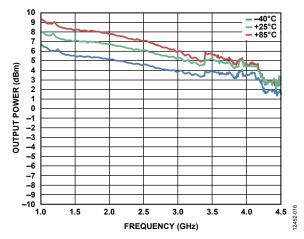


Figure 13. Output Power vs. Frequency, RFouTA+/RFouTA- (7.5 nH Inductors, 10 pF Bypass Capacitors, Board Losses De-Embedded)

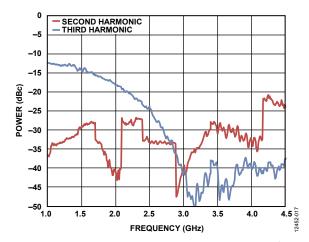


Figure 14. RFoutA+/RFoutA- Harmonics vs. Frequency (7.5 nH Inductors, 10 pF Bypass Capacitors, Board Losses De-Embedded)

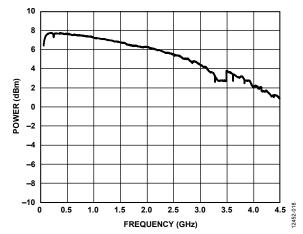


Figure 15. RF<sub>OUT</sub>A+/RF<sub>OUT</sub>A- Power vs. Frequency (100 nH Inductors, 100 pF Bypass Capacitors, Board Measurement)

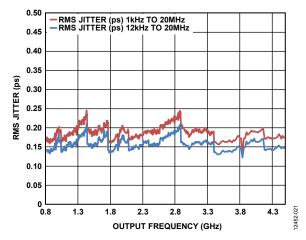


Figure 16. RMS Jitter vs. Output Frequency, PFD Frequency = 61.44 MHz, Loop Filter = 20 kHz

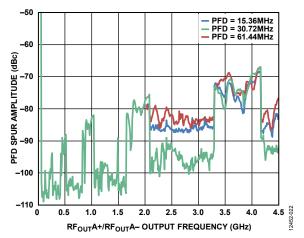


Figure 17. PFD Spur Amplitude vs. RF $_{OUT}$ A+/RF $_{OUT}$ A- Output Frequency, PFD = 15.36 MHz, PFD = 30.72 MHz, PFD = 61.44 MHz, Loop Filter = 20 kHz

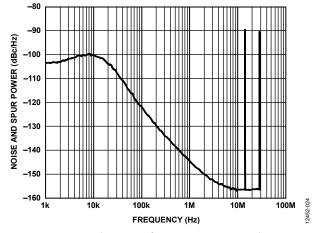


Figure 18. Fractional-N Spur Performance, GSM1800 Band, RFουπA+ = 1550.2 MHz, REF<sub>IN</sub> = 122.88 MHz, PFD = 61.44 MHz, Output Divide by 4 Selected, Loop Filter Bandwidth = 2 kHz, Channel Spacing = 20 kHz

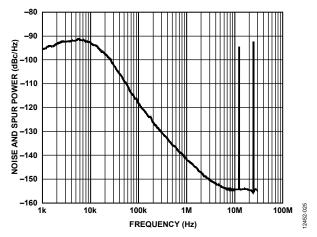


Figure 19. Fractional-N Spur Performance, W-CDMA Band, RF $_{\rm OUT}$ A+ = 2113.5 MHz, REF $_{\rm IN}$  = 122.88 MHz, PFD = 61.44 MHz, Output Divide by 2 Selected, Loop Filter Bandwidth = 2 kHz, Channel Spacing = 20 kHz

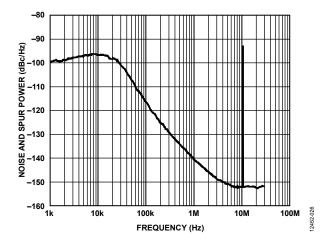


Figure 20. Fractional-N Spur Performance, RF<sub>OUT</sub>A+ = 2.591 GHz, REF<sub>IN</sub> = 122.88 MHz, PFD = 61.44 MHz, Output Divide by 2 Selected, Loop Filter Bandwidth = 2 kHz, Channel Spacing = 20 kHz

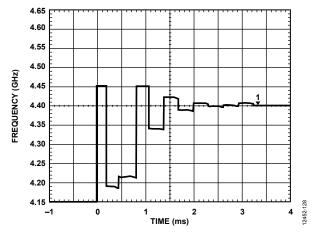


Figure 21. Lock Time for 250 MHz Jump from 4150 MHz to 4400 MHz, Loop Bandwidth = 20 kHz

# CIRCUIT DESCRIPTION REFERENCE INPUT SECTION

Figure 22 shows the reference input stage. The reference input can accept both single-ended and differential signals. Use the reference mode bit (Register 4, Bit DB9) to select the signal. To use a differential signal on the reference input, program this bit high. In this case, SW1 and SW2 are open, SW3 and SW4 are closed, and the current source that drives the differential pair of transistors switches on. The differential signal is buffered and it is provided to an emitter coupled logic (ECL) to CMOS converter. When a single-ended signal is used as the reference, program Bit DB9 in Register 4 to 0. Connect the single-ended reference signal to REF<sub>IN</sub>A. In this case, SW1 and SW2 are closed, SW3 and SW4 are open, and the current source that drives the differential pair of transistors switches off.

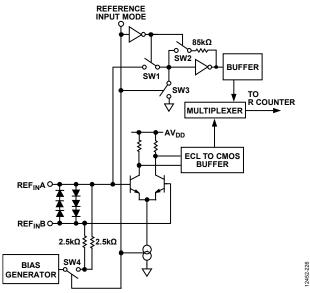


Figure 22. Reference Input Stage

#### **RF N DIVIDER**

The RF N divider allows a division ratio in the PLL feedback path. Determine the division ratio by the INT, FRAC1, FRAC2, and MOD2 values that this divider comprises.

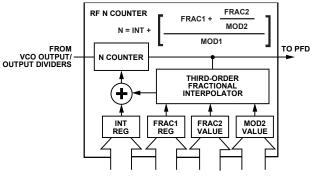


Figure 23. RF N Divider

#### INT, FRAC, MOD, and R Counter Relationship

The INT, FRAC1, FRAC2, MOD1, and MOD2 values, in conjunction with the R counter, make it possible to generate output frequencies that are spaced by fractions of the PFD frequency ( $f_{\text{PFD}}$ ). For more information, see the RF Synthesizer—A Worked Example section.

Calculate the RF VCO frequency (VCOOUT) by

$$VCO_{OUT} = f_{PFD} \times N \tag{1}$$

where:

*VCO*<sub>OUT</sub> is the output frequency of the VCO (without using the output divider).

 $f_{PFD}$  is the frequency of the phase frequency detector. N is the desired value of the feedback counter, N.

Calculate f<sub>PFD</sub> by

$$f_{PFD} = REF_{IN} \times [(1+D)/(R \times (1+T))]$$
 (2)

where:

*REF*<sub>IN</sub> is the reference input frequency.

D is the  $REF_{IN}$  doubler bit.

*R* is the preset divide ratio of the binary 10-bit programmable reference counter (1 to 1023).

T is the  $REF_{IN}$  divide by 2 bit (0 or 1).

N comprises

$$N = INT + \frac{FRAC1 + \frac{FRAC2}{MOD2}}{MOD1}$$
 (3)

where:

INT is the 16-bit integer value (23 to 32,767 for the 4/5 prescaler, 75 to 65,535 for the 8/9 prescaler).

*FRAC1* is the numerator of the primary modulus (0 to 16,777,215). *FRAC2* is the numerator of the 14-bit auxiliary modulus (0 to 16,383).

*MOD2* is the programmable, 14-bit auxiliary fractional modulus (2 to 16,383).

MOD1 is a 24-bit primary modulus with a fixed value of  $2^{24} = 16,777,216$ .

Equation 3 results in a very fine frequency resolution with no residual frequency error. To apply this formula, take the following steps:

- 1. Calculate N by dividing VCO<sub>OUT</sub>/f<sub>PFD</sub>.
- 2. The integer value of this number forms INT.
- 3. Subtract the INT value from the full N value.
- 4. Multiply the remainder by  $2^{24}$ .
- 5. The integer value of this number forms FRAC1.
- 6. Calculate MOD2 based on the channel spacing (f<sub>CHSP</sub>) by

$$MOD2 = f_{PFD}/GCD(f_{PFD}, f_{CHSP})$$
(4)

where:

 $GCD(f_{PFD}, f_{CHSP})$  is the greatest common divider of the PFD frequency and the channel spacing frequency.  $f_{CHSP}$  is the desired channel spacing frequency.

7. Calculate FRAC2 by the following equation:

$$FRAC2 = [(N - INT) \times 2^{24} - FRAC1)] \times MOD2$$
 (5)

The FRAC2 and MOD2 fraction results in outputs with zero frequency error for channel spacings when

$$f_{PFD}/GCD(f_{PFD}/f_{CHSP}) < 16,383$$
 (6)

where:

 $f_{PFD}$  is the frequency of the phase frequency detector. GCD is a greatest common denominator function.  $f_{CHSP}$  is the desired channel spacing frequency.

If zero frequency error is not required, the MOD1 and MOD2 denominators operate together to create a 38-bit resolution modulus.

#### **INT N Mode**

When FRAC1 and FRAC2 = 0, the synthesizer operates in integer-N mode.

#### R Counter

The 10-bit R counter allows the input reference frequency (REF<sub>IN</sub>) to be divided down to produce the reference clock to the PFD. Division ratios from 1 to 1023 are allowed.

## PHASE FREQUENCY DETECTOR (PFD) AND CHARGE PUMP

The PFD takes inputs from the R counter and N counter and produces an output proportional to the phase and frequency difference between them. Figure 24 is a simplified schematic of the phase frequency detector. The PFD includes a fixed delay element that sets the width of the antibacklash pulse. This pulse ensures that there is no dead zone in the PFD transfer function and provides a consistent reference spur level. Set the phase detector polarity to positive on this device because of the positive tuning of the VCO.

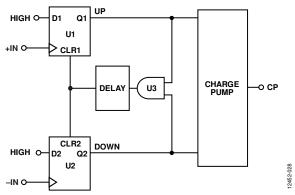


Figure 24. PFD Simplified Schematic

#### **MUXOUT AND LOCK DETECT**

The output multiplexer on the ADF4355-2 allows the user to access various internal points on the chip. The M3, M2, and M1 bits in Register 4 control the state of MUXOUT. Figure 25 shows the MUXOUT section in block diagram form.

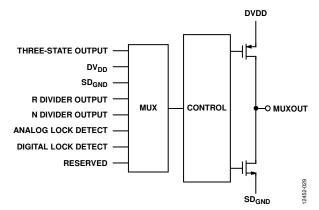


Figure 25. MUXOUT Schematic

#### INPUT SHIFT REGISTERS

The ADF4355-2 digital section includes a 10-bit R counter, a 16-bit RF integer-N counter, a 24-bit FRAC1 counter, a 14-bit auxiliary fractional counter, and a 14-bit auxiliary modulus counter. Data clocks into the 32-bit shift register on each rising edge of CLK. The data clocks in MSB first. Data transfers from the shift register to one of 12 latches on the rising edge of LE. The state of the four control bits (C4, C3, C2, and C1) in the shift register determines the destination latch. As shown in Figure 2, the four LSBs are DB3, DB2, DB1, and DB0. The truth table for these bits is shown in Table 5. Figure 28 and Figure 29 summarize the programing of the latches.

Table 5. Truth Table for the C4, C3, C2, and C1 Control Bits

	Cor	ntrol Bits		
C4	C3	C2	<b>C</b> 1	Register
0	0	0	0	Register 0
0	0	0	1	Register 1
0	0	1	0	Register 2
0	0	1	1	Register 3
0	1	0	0	Register 4
0	1	0	1	Register 5
0	1	1	0	Register 6
0	1	1	1	Register 7
1	0	0	0	Register 8
1	0	0	1	Register 9
1	0	1	0	Register 10
1	0	1	1	Register 11
1	1	0	0	Register 12

#### **PROGRAM MODES**

Table 5 and Figure 28 through Figure 42 show the program modes that must be set up in the ADF4355-2.

The following settings in the ADF4355-2 are double buffered: main fractional value (FRAC1), auxiliary modulus value (MOD2), auxiliary fractional value (FRAC2), reference doubler, reference divide by 2 (RDIV2), R counter value, and charge pump current setting. Two events must occur before the ADF4355-2 uses a new value for any of the double buffered settings. First, the new value must latch into the device by writing to the appropriate register, and second, a new write to Register 0 must be performed.

For example, to ensure that the modulus value loads correctly, every time the modulus value updates, Register 0 must be written to. The RF divider select in Register 6 is also double buffered, but only when DB14 of Register 4 is high.

#### **VCO**

The VCO core in the ADF4355-2 consists of four separate VCOs, each of which uses 256 overlapping bands, which allows covering a wide frequency range without a large VCO sensitivity ( $K_V$ ) and without resultant poor phase noise and spurious performance.

The correct VCO and band are chosen automatically by the VCO and band select logic when Register 0 is updated and auto-calibration is enabled. The VCO  $V_{\text{TUNE}}$  is disconnected from the output of the loop filter and is connected to an internal reference voltage.

The R counter output is used as the clock for the band select logic. After band selection, normal PLL action resumes. The nominal value of  $K_V$  is 15 MHz/V when the N divider is driven from the VCO output, or the  $K_V$  value is divided by D. D is the output divider value if the N divider is driven from the RF output divider (chosen by programming Bits[D23:D21] in Register 6).

The VCO shows variation of  $K_V$  as the tuning voltage,  $V_{TUNE}$ , varies within the band and from band to band. For wideband applications covering a wide frequency range (and changing output dividers), a value of 15 MHz/V provides the most accurate  $K_V$ , because this value is closest to the average value. Figure 26 shows how  $K_V$  varies with fundamental VCO frequency along with an average value for the frequency band. Users may prefer this figure when using narrow-band designs.

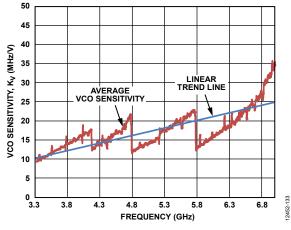


Figure 26. K<sub>V</sub> vs. Frequency

#### **OUTPUT STAGE**

The RF<sub>OUT</sub>A+ and RF<sub>OUT</sub>A- pins of the ADF4355-2 connect to the collectors of an NPN differential pair driven by buffered outputs of the VCO, as shown in Figure 27. In this scheme, the ADF4355-2 contains internal 50  $\Omega$  resistors connected to the  $V_{RF}$  pin. To optimize the power dissipation vs. the output power requirements, the tail current of the differential pair is programmable using Bits[D2:D1] in Register 6. Four current levels can be set. These levels give approximate output power levels of -4 dBm, -1 dBm, +2 dBm, and +5 dBm, respectively, using a 50  $\Omega$  resistor to  $V_{RF}$  and ac coupling into a 50  $\Omega$  load. For accurate power levels, refer to the Typical Performance Characteristics section. With an output power of 5 dBm, an external shunt inductor is necessary to provide higher power levels; however, this addition results in less wideband operation. Terminate the unused complementary output with a similar circuit to the used output.

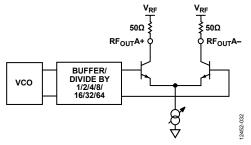


Figure 27. Output Stage

Another feature of the ADF4355-2 is that the supply current to the output stages can shut down until the ADF4355-2 achieves lock as measured by the digital lock detect circuitry. The mute till lock detect (MTLD) bit (DB11) in Register 6 enables this.

The RF $_{OUT}B+/RF_{OUT}B-$  pins are duplicate outputs that can be used independently or in addition to the RF $_{OUT}A+/RF_{OUT}A-$  pins.

Table 6. Total I<sub>DD</sub> (RF<sub>OUT</sub>A± Refers to RF<sub>OUT</sub>A+/RF<sub>OUT</sub>A-)

Divide By	RF <sub>OUT</sub> A± Off	$RF_{OUT}A\pm = -4 dBm$	$RF_{OUT}A\pm = -1 dBm$	$RF_{OUT}A\pm = +2 dBm$	RF <sub>OUT</sub> A± = +5 dBm
5 V Supply (I <sub>VCO</sub> and I <sub>P</sub> )	78 mA	78 mA	78 mA	78 mA	78 mA
3.3 V Supply (Aldd, Dldd, Irf)					
1	79.8 mA	101.3 mA	111.9 mA	122.7 mA	132.8 mA
2	87.8 mA	110.1 mA	120.6 mA	131.9 mA	141.9 mA
4	97.1 mA	119.3 mA	130.1 mA	141.6 mA	152.1 mA
8	104.9 mA	127.1 mA	137.8 mA	149.2 mA	159.7 mA
16	109.8 mA	131.8 mA	142.7 mA	154.1 mA	164.6 mA
32	113.6 mA	135.5 mA	146.5 mA	157.8 mA	168.4 mA
64	115.9 mA	137.8 mA	148.9 mA	160.1 mA	170.8 mA

### **REGISTER MAPS**

#### **REGISTER 0**

															J	. •															
				RESER	VED					AUTOCAL	PRESCALER							16-B	IT INTE	EGER \	/ALUE	(INT)							CONT BI		
DB31	DB30	DB29	DB28	DB27	DB26	DB25	DB24	DB23	DB22	DB21	DB20	DB19	DB18	DB17	DB16	DB15	DB14	DB13	DB12	DB11	DB10	DB9	DB8	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0
$\bigcap$	0	0	0	0	0	0	0	0	0	AC1	PR1	N16	N15	N14	N13	N12	N11	N10	N9	N8	N7	N6	N5	N4	N3	N2	N1	C4(0)	C3(0)	C2(0)	C1(0)

#### **REGISTER 1**

	RESI	ERVED									24-	BIT MA	IN FRA	CTION	AL VAL	UE (FR	AC1)	DB	R <sup>1</sup>										CONT		
DB3	DB30	DB29	DB28	DB27	DB26	DB25	DB24	DB23	DB22	DB21	DB20	DB19	DB18	DB17	DB16	DB15	DB14	DB13	DB12	DB11	DB10	DB9	DB8	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0
C	0	0	0	F24	F23	F22	F21	F20	F19	F18	F17	F16	F15	F14	F13	F12	F11	F10	F9	F8	F7	F6	F5	F4	F3	F2	F1	C4(0)	C3(0)	C2(0)	C1(1)

#### **REGISTER 2**

	14-BIT AUXILIARY FRACTIONAL VALUE (FRAC2) DBR1																14-B	IT AUXI	LIARY	MODU	LUS V	ALUE (	MOD2)	DBR	1				CONT	ROL TS	
DB31	DB30	DB29	DB28	DB27	DB26	DB25	DB24	DB23	DB22	DB21	DB20	DB19	DB18	DB17	DB16	DB15	DB14	DB13	DB12	DB11	DB10	DB9	DB8	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0
F14	F13	F12	F11	F10	F9	F8	F7	F6	F5	F4	F3	F2	F1	M14	M13	M12	M11	M10	М9	М8	М7	М6	М5	M4	МЗ	M2	M1	C4(0)	C3(0)	C2(1)	C1(0)

#### **REGISTER 3**

RESERVED	SD LOAD RESET	PHASE RESYNC	PHASE ADJUST									2	4-BIT P	PHASE '	VALUE	(PHAS	Ε)	DB	R <sup>1</sup>										CONT	TROL TS	
DB31	DB30	DB29	DB28	DB27	DB26	DB25	DB24	DB23	DB22	DB21	DB20	DB19	DB18	DB17	DB16	DB15	DB14	DB13	DB12	DB11	DB10	DB9	DB8	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0
C	SD1	PR1	PA1	P24	P23	P22	P21	P20	P19	P18	P17	P16	P15	P14	P13	P12	P11	P10	P9	P8	P7	P6	P5	P4	Р3	P2	P1	C4(0)	C3(0)	C2(1)	C1(1)

#### **REGISTER 4**

RES	ERVED		иихои	т	REFERENCE DOUBLER DBR1	RDIV2 DBR1				10-B	IT R CC	DUNTER	R	DE	BR1		DOUBLE BUFF	CI S	JRREN' ETTING	T ; Di	BR¹	REF MODE	MUX LOGIC	PD POLARITY	8	CP THREE- STATE	COUNTER RESET		CONT		
DB3	DB30	DB29	DB28	DB27	DB26	DB25	DB24	DB23	DB22	DB21	DB20	DB19	DB18	DB17	DB16	DB15	DB14	DB13	DB12	DB11	DB10	DB9	DB8	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0
acksquare	0	МЗ	M2	M1	RD2	RD1	R10	R9	R8	R7	R6	R5	R4	R3	R2	R1	D1	CP4	СРЗ	CP2	CP1	U6	U5	U4	UЗ	U2	U1	C4(0)	C3(1)	C2(0)	C1(0)

#### **REGISTER 5**

													RESE	RVED															CON		
DB	1 DB30	DB29	DB28	DB27	DB26	DB25	DB24	DB23	DB22	DB21	DB20	DB19	DB18	DB17	DB16	DB15	DB14	DB13	DB12	DB11	DB10	DB9	DB8	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0
$\Gamma$	0	0	0	0	0	0	0	1	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	0	C4(0)	C3(1)	C2(0)	C1(1)

#### **REGISTER 6**

RESERVED	GATED BLEED	NEGATIVE BLEED		RESE	RVED		FEEDBACK SELECT		DIVID			СН	ARGE I	PUMP	BLEED	CURR	ENT		RESERVED	MTLD	RESERVED	AUX RF OUTPUT ENABLE	AUX OUT POV	PUT	RF OUTPUT ENABLE	R OUT POV	PUT		CONT BIT		
DB31	DB30	DB29	DB28	DB27	DB26	DB25	DB24	DB23	DB22	DB21	DB20	DB19	DB18	DB17	DB16	DB15	DB14	DB13	DB12	DB11	DB10	DB9	DB8	DB7	DB6	DB5	DB4	DB3	DB2	DB1	DB0
Co	BL10	BL9	1	0	1	0	D13	D12	D11	D10	BL8	BL7	BL6	BL5	BL4	BL3	BL2	BL1	0	D8	0	D6	D5	D4	D3	D2	D1	C4(0)	C3(1)	C2(1)	C1(0)

<sup>1</sup>DBR = DOUBLE BUFFERED REGISTER—BUFFERED BY THE WRITE TO REGISTER 0.
<sup>2</sup>DBB = DOUBLE BUFFERED BITS—BUFFERED BY A WRITE TO REGISTER 0 WHEN BIT DB14 OF REGISTER 4 IS HIGH.

#### **REGISTER 7** FRAC-N LD PRECISION LDO MODE MODE 2 CONTROL RESERVED RESERVED DB30 DB29 DB28 DB25 DB24 DB23 DB22 DB21 DB20 DB19 DB18 DB17 DB16 DB15 DB14 DB13 DB12 DB11 DB10 DB9 DB8 DB5 DB4 DB7 DB6 DB1 0 0 **REGISTER 8** CONTROL BITS RESERVED DB21 DB20 DB19 DB30 DB27 DB26 DB25 DB24 DB23 DB22 DB18 DB17 DB16 DB15 DB14 DB13 DB12 DB11 DB10 DB9 DB8 DB7 DB6 DB5 DB4 DB3 DB2 DB1 0 0 0 0 0 0 0 0 0 0 1 0 1 1 0 0 0 0 0 C4(1) C3(0) C2(0) C1(0) **REGISTER 9** SYNTHESIZER LOCK TIMEOUT CONTROL DB27 DB26 DB24 DB23 DB22 DB21 DB20 DB19 DB18 DB17 DB16 DB15 DB14 DB13 DB12 DB11 DB10 DB9 DB8 DB7 DB5 DB30 DB29 DB28 DB25 DB6 DB1 DB2 VC7 VC6 VC5 VC3 VC2 VC1 TL10 TL9 TL8 TL7 TL6 TL5 TL4 TL3 TL2 TL1 AL5 AL4 AL3 AL2 AL1 SL5 SL4 SL3 SL2 SL1 **REGISTER 10** ADC CONVERSION ADC ENABLE CONTROL BITS ADC CLOCK DIVIDER RESERVED DB28 DB25 DB24 DB22 DB21 DB20 DB19 DB18 DB17 DB16 DB15 DB14 DB13 DB12 DB11 DB10 DB9 DB8 DB7 DB6 DB5 DB4 DB3 DB2 DB1 DB30 DB29 DB27 DB26 DB23 0 0 0 0 0 AD8 AD7 AD6 AD5 AD4 AD3 AD1 AE2 0 0 0 0 0 0 0 **REGISTER 11** CONTROL BITS RESERVED DB31 DB30 DB29 DB28 DB27 DB26 DB25 DB24 DB23 DB22 DB21 DB19 DB18 DB17 DB16 DB15 DB14 DB13 DB12 DB11 DB10 DB8 DB7 DB5 DB4 DB3 DB2 DB20 DB9 DB6 DB1 0 0 0 0 0 0 0 0 0 0 C2(1) C1(1) **REGISTER 12** CONTROL RESYNC CLOCK RESERVED

0 Figure 29. Register Summary (Register 7 to Register 12)

P2

P1

P3

DB30

P15

P14

DB29 DB28 DB27 DB26 DB25

P12

P11 P10 P9 P8 P7 P6

P13

DB24 DB23 DB22 DB21

DB20 DB19 DB18 DB17 DB16 DB15 DB14 DB13 DB12 DB11 DB10 DB9

0

DB8 DB7 DB6 DB5 DB4 DB3 DB2 DB1 DB0

> 0 0 0

C3(1)

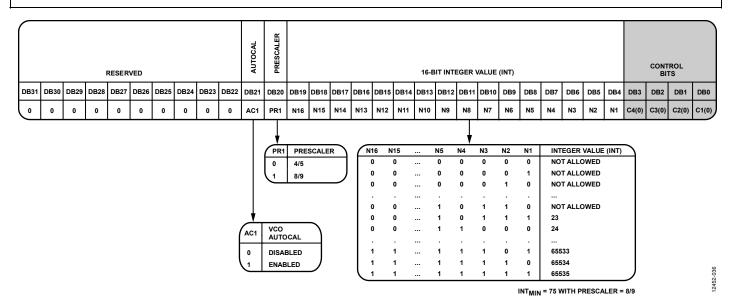


Figure 30. Register 0

#### **REGISTER 0**

#### **Control Bits**

With Bits[C4:C1] set to 0000, Register 0 is programmed. Figure 30 shows the input data format for programming this register.

#### Reserved

Bits[DB31:DB22] are reserved and must be set to 0.

#### **Automatic Calibration (Autocalibration)**

Write to Register 0 to enact (by default) the VCO autocalibration, and to choose the appropriate VCO and VCO subband. Write 1 to the AC1 bit (Bit DB21) to enable the autocalibration, which is the recommended mode of operation.

Set the AC1 bit to 0 to disable the autocalibration, which leaves the ADF4355-2 in the same band it was already in when Register 0 is updated.

Disable the autocalibration only for fixed frequency applications, phase adjust applications, or very small (<10 kHz) frequency jumps. Toggling autocalibration is also required when changing frequency (see the Frequency Update Sequence section for additional details).

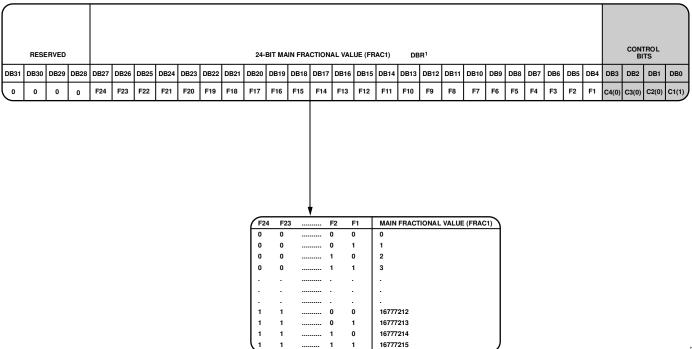
#### **Prescaler Value**

The dual modulus prescaler (P/P + 1), along with the INT, FRACx, and MODx counters, determines the overall division ratio from the VCO output to the PFD input. The PR1 bit (Bit DB20) in Register 0 sets the prescaler value.

Operating at CML levels, the prescaler takes the clock from the VCO output and divides it down for the counters. It is based on a synchronous 4/5 core. When the prescaler is set to 4/5, the maximum RF frequency allowed is 7 GHz. The prescaler limits the INT value; therefore, if P is 4/5,  $N_{\rm MIN}$  is 23, and if P is 8/9,  $N_{\rm MIN}$  is 75.

#### 16-Bit Integer Value

The 16 INT bits (Bits[DB19:DB4]) set the INT value, which determines the integer part of the feedback division factor. The INT value is used in Equation 3 (see the INT, FRAC, MOD, and R Counter Relationship section). All integer values from 23 to 32,767 are allowed for the 4/5 prescaler. For the 8/9 prescaler, the minimum integer value is 75, and the maximum value is 65,535.



<sup>1</sup>DBR = DOUBLE BUFFERED REGISTER—BUFFERED BY THE WRITE TO REGISTER 0.

Figure 31. Register 1

#### **REGISTER 1**

#### **Control Bits**

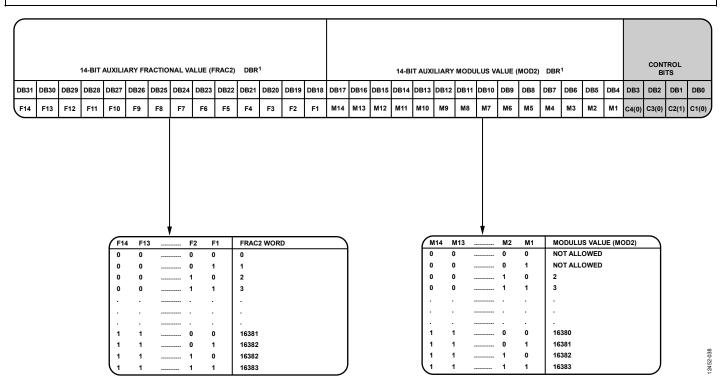
With Bits[C4:C1] set to 0001, Register 1 is programmed. Figure 31 shows the input data format for programming this register.

#### Reserved

Bits[DB31:DB28] are reserved and must be set to 0.

#### 24-Bit Main Fractional Value

The 24 FRAC1 bits (Bits[DB27:DB4]) set the numerator of the fraction that is input to the sigma-delta ( $\Sigma$ - $\Delta$ ) modulator. This fraction, along with the INT value, specifies the new frequency channel that the synthesizer locks to, as shown in the RF Synthesizer—A Worked Example section. FRAC1 values from 0 to (MOD1 – 1) cover channels over a frequency range equal to the PFD reference frequency.



<sup>1</sup>DBR = DOUBLE BUFFERED REGISTER—BUFFERED BY THE WRITE TO REGISTER 0.

Figure 32. Register 2

#### **REGISTER 2**

#### **Control Bits**

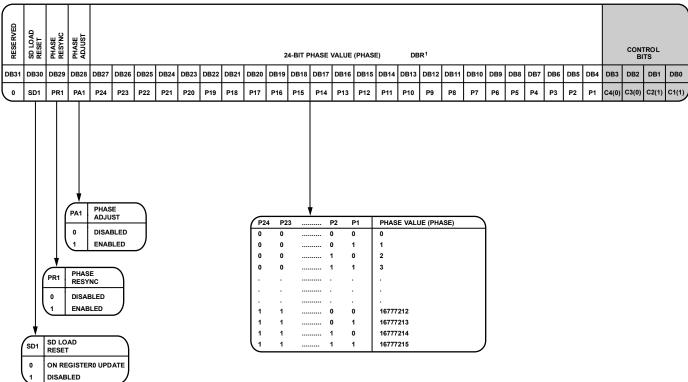
With Bits[C4:C1] set to 0010, Register 2 is programmed. Figure 32 shows the input data format for programming this register.

#### 14-Bit Auxiliary Fractional Value (FRAC2)

The 14-bit auxiliary fractional value (Bits[DB31:DB18]) controls the auxiliary fractional word. FRAC2 must be less than the MOD2 value programmed in Register 2.

#### 14-Bit Auxiliary Modulus Value (MOD2)

The 14-bit auxiliary modulus value (Bits[DB17:DB4]) sets the auxiliary fractional modulus. Use MOD2 to correct any residual error due to the main fractional modulus.



<sup>1</sup>DBR = DOUBLE BUFFERED REGISTER—BUFFERED BY THE WRITE TO REGISTER 0.

Figure 33. Register 3

#### **REGISTER 3**

#### **Control Bits**

With Bits[C4:C1] set to 0011, Register 3 is programmed. Figure 33 shows the input data format for programming this register.

#### Reserved

Bit DB31 is reserved and must be set to 0.

#### **SD Load Reset**

When writing to Register 0, the  $\Sigma$ - $\Delta$  modulator resets. For applications in which the phase is continually adjusted, this may not be desirable; therefore, in these cases, the  $\Sigma$ - $\Delta$  reset can be disabled by writing a 1 to the SD1 bit (Bit DB30).

#### **Phase Resync**

To use the phase resynchronization feature, the PR1 bit (Bit DB29) must be set to 1. If unused, the bit can be programmed to 0. The phase resync timer must also be used in Register 12 to ensure that the resynchronization feature is applied after PLL has settled to the final frequency. If the PLL has not settled to the final frequency, phase resync may not function correctly. Resynchronization is useful in phased array and beam forming applications. It ensures repeatability of output phase when programming the same frequency. In phase critical applications that use frequencies requiring the output divider (<3400 MHz), it is necessary to feed the N divider with the divided VCO frequency as distinct from the fundamental VCO frequency.

This is achieved by programming the D13 bit (Bit DB24) in Register 6 to 0, which ensures divided feedback to the N divider. Phase resynchronization only operates when FRAC2 = 0.

For resync applications, enable the SD load reset in Register 3 by setting DB30 to 0.

#### **Phase Adjust**

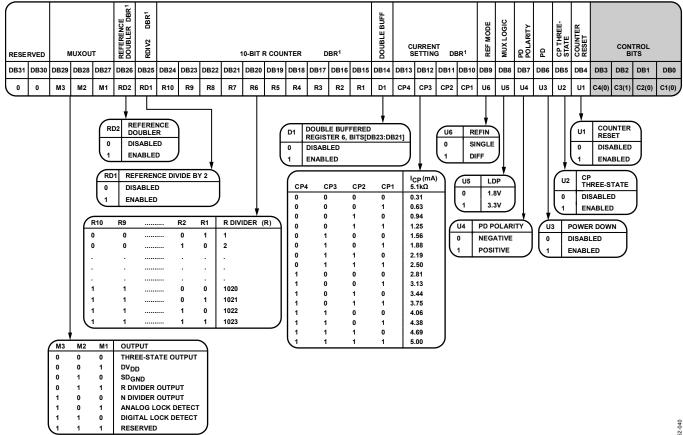
To adjust the relative output phase of the ADF4355-2 on each Register 0 update, set the PA1 bit (Bit DB28) to 1. This feature differs from the resynchronization feature in that it is useful when adjustments to phase are made continually in an application. For this function, disable the VCO autocalibration by setting the AC1 bit (Bit DB21) in Register 0 to 1, and disable the SD load reset by setting the SD1 bit (Bit DB30) in Register 3 to 1. Note that phase resync and phase adjust cannot be used simultaneously.

#### 24-Bit Phase Value

The phase of the RF output frequency can adjust in 24-bit steps; from  $0^{\circ}$  (0) to  $360^{\circ}$  ( $2^{24} - 1$ ). For phase adjust applications, the phase is set by

(Phase Value/16,777,216) × 360°

When the phase value is programmed to Register 3, each subsequent adjustment of Register 0 increments the phase by the value in this equation.



<sup>1</sup>DBR = DOUBLE BUFFERED REGISTER—BUFFERED BY THE WRITE TO REGISTER 0.

Figure 34. Register 4

#### **REGISTER 4**

#### **Control Bits**

With Bits [C4:C1] set to 0100, Register 4 is programmed. Figure 34 shows the input data format for programming this register.

#### Reserved

Bits[DB31:DB30] are reserved and must be set to 0.

#### MUXOUT

The on-chip multiplexer (MUXOUT) is controlled by Bits[DB29:DB27]. For additional details, see Figure 34.

#### Reference Doubler

Setting the RD2 bit (Bit DB26) to 0 feeds the REF<sub>IN</sub> signal directly to the 10-bit R counter, disabling the doubler. Setting this bit to 1 multiplies the reference frequency by a factor of 2 before feeding it into the 10-bit R counter. When the doubler is disabled, the  $REF_{IN}$  falling edge is the active edge at the PFD input to the fractional synthesizer. When the doubler is enabled, both the rising and falling edges of the reference frequency become active edges at the PFD input.

The maximum allowable reference frequency when the doubler is enabled is 100 MHz.

Setting the RDIV2 bit (Bit DB25) to 1 inserts a divide by 2 toggle flip-flop between the R counter and PFD, which extends the maximum reference frequency input rate. This function provides a 50% duty cycle signal at the PFD input.

#### 10-Bit R Counter

The 10-bit R counter divides the input reference frequency  $(REF_{\mathrm{IN}})$  to produce the reference clock to the PFD. Division ratios range from 1 to 1023.

#### **Double Buffer**

The D1 bit (Bit DB14) enables or disables double buffering of the RF divider select bits (Bits[DB23:DB21]) in Register 6. The section explains how double buffering works.

#### **Charge Pump Current Setting**

The CP4 to CP1 bits (Bits[DB13:DB10]) set the charge pump current. Set this value to the charge pump current for which the loop filter is designed (see Figure 34). For the lowest spurs, the 0.9 mA setting is recommended.

#### Reference Mode

The ADF4355-2 permits use of either differential or single-ended reference sources. For differential sources, set the reference mode bit (Bit DB9) to 1, and set it to 0 for single-ended sources.

For optimum integer boundary spur performance, use the single-ended setting for all references up to 250 MHz (even if using a differential reference signal). Use the differential setting for reference frequencies above 250 MHz.

#### **Level Select**

To assist with logic compatibility, MUXOUT is programmable to two logic levels. Set the U5 bit (Bit DB8) to 0 to select 1.8 V logic, and set it to 1 to select 3.3 V logic.

#### **Phase Detector Polarity**

The U4 bit (Bit DB7) sets the phase detector polarity. When a passive loop filter or a noninverting active loop filter is used, set DB7 to 1 (positive). If an active filter with an inverting characteristic is used, set this bit to 0 (negative).

#### Power-Down

The U3 bit (Bit DB6) sets the programmable power-down mode. Setting DB6 to 1 performs a power-down. Setting DB6 to 0 returns the synthesizer to normal operation. In software power-down mode, the ADF4355-2 retains all information in its registers. The register contents are only lost if the supply voltages are removed.

When power-down activates, the following events occur:

- The synthesizer counters are forced to their load state conditions.
- The VCO powers down.
- The charge pump is forced into three-state mode.
- The digital lock detect circuitry resets.
- The RF<sub>OUT</sub>A+/RF<sub>OUT</sub>A- and RF<sub>OUT</sub>B+/RF<sub>OUT</sub>B- output stages are disabled.
- The input registers remain active and capable of loading and latching data.

#### **Charge Pump Three-State**

Setting the U2 bit (Bit DB5) to 1 puts the charge pump into three-state mode. Set DB5 to 0 for normal operation.

#### **Counter Reset**

The U1 bit (Bit DB4) resets the R counter, N counter, and VCO band select of the ADF4355-2. When DB4 is set to 1, the RF synthesizer N counter and R counter and the VCO band select are reset. For normal operation, set DB4 to 0. Toggling counter reset (Bit DB4) is also required when changing frequency (see the Frequency Update Sequence section for additional details).

#### **REGISTER 5**

The bits in Register 5 are reserved and must be programmed as described in Figure 35, using a hexadecimal word of 0x00800025.

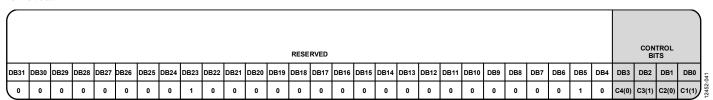


Figure 35. Register 5 (0x00800025)